

**Search Notes**

Application/Control No.

10/506,410

Examiner

Tai Duong

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2871

**SEARCHED**

Class	Subclass	Date	Examiner
349	38,43	3/18/2006	TD
	128, 129		
	130, 139		
	139,167		
	177		
257	59		
	72		
345	92		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US PG PUB, US PAT, EPO, JPO, DERWENT, IBM TDB)	3/18/2006	TD